Linear and nonlinear optical properties of BiFeO$_3$

Amit Kumar,$^{1,a}$ Ram C. Raj,$^2$ Nikolas J. Podraza,$^1$ Sava Denev,$^1$ Mariola Ramirez,$^1$
Ying-Hao Chu,$^3$ Lane W. Martin,$^3$ Jon Ihlefeld,$^1$ T. Heeg,$^4$ J. Schubert,$^4$ Darrell G. Schlom,$^1$
J. Orenstein,$^5$ R. Ramesh,$^3$ Robert W. Collins,$^6$ Janice L. Musfeldt,$^2$ and
Venkatraman Gopalan$^{1,b}$

$^1$Department of Materials Science and Engineering, MRL Bldg., Pennsylvania State University,
University Park, Pennsylvania 16802, USA
$^2$Department of Chemistry, University of Tennessee, Knoxville, Tennessee 37996, USA
$^3$Department of Materials Science and Engineering, University of California, Berkeley,
Hearst Mining Building, Berkeley, California 94720, USA
$^4$Institute of Bio- and Nano-Systems (IBN1-IT), Research Centre Jülich, Jülich D-52425, Germany
$^5$Department of Physics, University of California, Berkeley, California 94720, USA
$^6$Department of Physics and Astronomy, University of Toledo, Toledo, Ohio, 43606, USA

(Received 8 January 2008; accepted 4 March 2008; published online 26 March 2008)

Using spectroscopic ellipsometry, the room temperature refractive index and absorption versus wavelength of the ferroelectric antiferromagnet bismuth ferrite, BiFeO$_3$, are reported. The material has a direct band gap at 442 nm wavelength (2.81 eV). Using optical second harmonic generation, the nonlinear optical coefficients were determined to be $d_{15}/d_{22}=0.20 \pm 0.01$, $d_{31}/d_{22} = 0.35 \pm 0.02$, $d_{33}/d_{22}=-11.4 \pm 0.20$, and $|d_{22}|=298.4 \pm 6.1$ pm/V at a fundamental wavelength of 800 nm. © 2008 American Institute of Physics.

BiFeO$_3$ (BFO) is an antiferromagnetic, ferroelectric with Neel temperature $T_N=643$ K, and ferroelectric Curie temperature $T_C=1103$ K.$^{1,3}$ It is presently one of the most studied multiferroic materials due to its large ferroelectric polarization of $\sim 100 \mu$C/cm$^2$ in thin films and the possibility of coupling between magnetic and ferroelectric order parameters, thus enabling manipulation of one through the other.$^2$ Linear and nonlinear optical spectroscopy tools are ideally suited to study such coupling.$^4$ While the mean refractive index for bulk single crystal BiFeO$_3$ has been previously investigated,$^5$ the optical constants of thin films have not been presented, thus far. Also, an indirect gap at 673 nm (1.84 eV) was reported before,$^6$ which is shown here to be an absorption onset potentially due to a joint density of states effect and not associated with phonon participation. In our analysis, the material appears to have a direct gap with a band edge at 442 nm instead. No studies of nonlinear optical coefficients of BFO, in any form, exist. In this letter, we measure large second order optical nonlinearities in BFO.

Epitaxial and phase-pure BFO thin films were synthesized by pulsed-laser deposition as well as molecular-beam epitaxy (MBE) on (111) SrTiO$_3$ (STO) substrates.$^{1,7}$ The films studied here are epitaxial with orientation relationship BFO(0001)∥STO(111) and [2110]BFO∥[110] STO. We specifically note that unlike many epitaxial thin films, these films do not have any additional structural variants, including any rotational variants within the film growth plane. Thus, these (0001) oriented films have nearly single crystalline perfection, with three well-defined crystallographic $x$-[2110], and $y$-[1100] axes within the film plane, and the $z$-[0001] axis normal to the plane. The three $y$-$z$ mirror planes in the 3$m$ point group symmetry for BFO are thus well-defined and allow us to precisely extract nonlinear coefficients without ambiguity. Typical film stoichiometry, as determined by Rutherford backscattering spectrometry, was stoichiometric within $\sim 3\%$ error of the measurement (Bi:Fe =0.98–0.99:1). There were no amorphous or secondary phases as confirmed by transmission electron microscopy. Ellipsometric spectra in $(\Delta, \Psi)$ were collected ex situ for a BiFeO$_3$ film prepared by MBE on (111) SrTiO$_3$ at $\theta_i=55^\circ$ and $70^\circ$ angles of incidence using a variable-angle rotating-compensator multichannel spectroscopic ellipsometer$^8$ with a spectral range from 190 to 1670 nm. The optical properties $(n, k)$ shown in Fig. 1(a) and the corresponding dielectric function spectra $(\varepsilon_1, \varepsilon_2)$ are extracted by using a least squares regression analysis and a weighted root mean square error$^9$ to fit the ellipsometric spectra to a four-medium optical model consisting of a semi-infinite STO.

FIG. 1. (Color online) (a) Index of refraction $(n)$ and extinction coefficient $(k)$ for BiFeO$_3$ deposited on (111) SrTiO$_3$ over a spectral range from 190 to 1670 nm. Also shown are the dielectric function parameters for the three Tauc–Lorentz oscillators (TL 1, TL 2, and TL 3) within the spectral range. The parametrization also includes an additional oscillator outside the spectral range with $E_g=7.29 \pm 0.06$ eV, $\Gamma=4.28 \pm 0.34$ eV, and $A=51.19 \pm 2.78$ eV. (b) Plot of $(\alpha E)^{1/2}$ and $(\alpha E)^2$ vs photon energy $E$ where a linear extrapolation of $(\alpha E)^2$ to $0$ suggests a direct band gap at 2.81 eV.

---

$^a$Electronic mail: auk183@psu.edu.
$^b$Electronic mail: vgopalan@psu.edu.
The free parameters correspond to the bulk and surface roughness thicknesses of the film and a parametrization of the BiFeO$_3$ dielectric function. The dielectric function parametrization of BiFeO$_3$ consists of four Tauc–Lorentz oscillators$^{10}$ sharing a common band gap and a constant additive term to $e_1$, denoted by $e_0$ (equal to 1 for this model). The parameters corresponding to each oscillator include an oscillator amplitude $A$, broadening parameter $\Gamma$, resonance energy $E_0$, and a Tauc gap $E_g$ common to all oscillators. The optical properties of the surface roughness layer are represented by a Bruggeman effective medium approximation consisting of a 0.50 bulk film/0.50 void mixture.$^{11}$ This model yields the common Tauc gap $E_g=2.15 \pm 0.06$ eV, bulk thickness $d_B=468.93 \pm 0.78$ Å, and surface roughness thickness $d_s=75.39 \pm 0.4$ Å.

We note that although the Tauc gap at 2.15 eV ($577$ nm) represents the onset of absorption, it is not the indirect gap, as claimed in literature.$^6$ A plot of $\alpha^2E^2$ vs photon energy $E$ ($\alpha=4\pi k/l$) and the linear extrapolation to $\alpha^2E^2=0$ indicates a direct gap at 2.81 eV ($442$ nm), as shown in Fig. 1(b). This value is in good agreement with that obtained from more recent optical measurements.$^{15,16}$ Band gap measurements on different MBE-grown BiFeO$_3$ films grown on (001) and (111) SrTiO$_3$ substrates revealed a direct band gap in all cases with $E_g=2.77 \pm 0.04$ eV. The presence of two distinct slopes in $(\alpha E)^{1/2}$ vs $E$ characteristic of an indirect band gap$^{12}$ is not observed. We obtain the linear complex indices from this model to be $N_p^0=2.836+0.0i$ and $N_s^0=3.444+0.981i$ for corresponding wavelengths of 800 and 400 nm, respectively. It should be noted that although BiFeO$_3$ is uniaxially anisotropic, only the optical properties of the ordinary index of refraction have been obtained for this film.$^{14}$

The crystal symmetry of epitaxial BFO(111) films has been shown to be point group 3m using optical second harmonic generation (SHG) and diffraction techniques.$^7$ Optical SHG (Ref. 15) involves the conversion of light (electric field $E^o$) at a frequency $\omega$ into an optical signal at a frequency 2$\omega$ by a nonlinear medium through the creation of a nonlinear polarization $P_{2\omega}=d_{ij}E^oE_{i\omega}$, where $d_{ij}$ represent the nonlinear optical coefficients. A BFO film with thickness of about 50 nm grown on STO(111) substrates was used for this study. STO is centrosymmetric (cubic) and does not contribute SHG signals of its own for the incident powers used. The SHG experiment was performed with a fundamental wave generated from a tunable Ti-sapphire laser with 65 fs pulses with wavelength of 800 nm incident from the substrate side at variable tilt angles $\theta$ to the sample surface normal.

As shown in Fig. 2(a), the crystallographic $y$-$z$ plane in the BFO film was aligned with the incidence plane. The polarization direction of incident light is at an angle $\phi$ from the $x$ axis, which was continuously rotated using a half-wave plate. The intensity $I_{\phi}^{2\omega}$ of the output SHG signal at 400 nm wavelength from the film was detected along either $j=p,s$ polarization directions as a function of polarization angle $\phi$ of incident light. The resulting polar plots of SHG intensity for $p$ and $s$ polarized outputs, $I_p^{2\omega}(\phi)$ and $I_s^{2\omega}(\phi)$, at tilt angles $\theta=0^\circ$ and $45^\circ$ are shown in Figs. 2(b) and 2(c), respectively. If the incident beam has an intensity $I_0$, then the nonlinear polarizations for BFO(111) film with $x$ axis perpendicular to the plane of incidence is given by$^{16,17}$

$$P_{NL}^p = I_0 f_x \sin 2\phi (d_{15} f_x \sin \theta - d_{22} f_x \cos \theta),$$

$$P_{NL}^s = I_0 (-d_{22} \cos^2 \phi f_{s}^2 + d_{22} f_{s}^2 \cos^2 \theta \sin^2 \phi + d_{15} f_{s} \sin 2\theta \sin^2 \phi),$$

$$P_{NL}^s = I_0 (d_{31} \cos^2 \phi f_{s}^2 + d_{31} f_{s}^2 \cos^2 \theta \sin^2 \phi + d_{33} f_{s}^2 \sin^2 \theta \sin^2 \phi),$$

where $d_{ij}$ are nonlinear coefficients and $f_{i}$ are effective linear Fresnel coefficients.

The measured intensity of the $p$ and $s$ output polarizations in the predicted $3m$ symmetry system of BFO are

$$I_p^{2\omega} = A(\cos^2 \phi + B \sin^2 \phi)^2,$$

$$I_s^{2\omega} = C \sin^2 2\phi,$$

where $B$ and $C$ are given by

$$B = \frac{K_{15} f_x \sin 2\theta \cos \theta_R + K_{31} f_s^2 \cos^2 \theta \sin \theta_R + K_{33} f_s^2 \sin^2 \theta \sin \theta_R + f_s^2 \cos^2 \theta \cos \theta_R}{K_{33} f_s^2 \sin \theta_R - f_s^2 \cos \theta_R},$$

$$C = D(K_{15} f_x \sin \theta - f_s f_x \cos \theta).$$
Here, $K_{15} = d_{15}/d_{22}$, $K_{31} = d_{31}/d_{22}$, and $K_{33} = d_{33}/d_{22}$ are the ratios of the nonlinear optical coefficients, $A$ and $D$ are scaling parameters, and $\theta_r$ is the angle that the generated second harmonic wave makes with the surface normal inside the film. Theoretical fits to the experimental polar plots based on Eq. (2) are excellent both in normal incidence and tilted configuration, as shown in Figs. 2(b) and 2(c), respectively, for both $p$ and $s$ polarized SHG outputs. In normal incidence ($\theta_r = 0^\circ$), only the $d_{22}$ coefficient is involved in the generated $I_p^{2\omega}(\phi=0^\circ)$. By using the $d_{22} = 1.672 \text{ pm/V}$ coefficient of a single crystal $z$-cut LiTaO$_3$ used as a reference, the $d_{22}$ coefficient of the BFO film is calculated by employing the following equation:

$$
\frac{d_{22}^2}{d_{r}^2} = \frac{P_{r}^{2\omega}A_{r}^{2\omega}}{P_{f}^{2\omega}A_{f}^{2\omega}} \frac{1}{l_{c,r}f_0^1 \left( \chi^2 r^{-2\omega} f_{x r} f_{x r} \right) \left( x_{r} ^2 r^{-2\omega} f_{x r} f_{x r} \right) dx},
$$

where the subscripts $r$ and $f$ refer to the reference and the film, respectively, $P_{r}^{2\omega}(P_{f}^{2\omega})$ are the second harmonic (fundamental) signal powers measured, $T$ is the transmission coefficient of the fundamental, $A$ is the area of the probed beam, $n$ are the indices of refraction, $l_c$ the coherence lengths, and $a=4\pi k/\lambda$ is the absorption coefficient at $2\omega$. For this experiment, $A_f = A_r = \pi(60 \mu m)^2$ and the coherence length of the film $l_c$ is equal to the film thickness.

The $B$ and $C$ parameters, which contain the ratios of nonlinear coefficients, are experimentally obtained by collecting the $p$-in-$p$-out $I_p^{2\omega}(\phi=90^\circ)$, $s$-in-$p$-out $I_p^{2\omega}(\phi=0^\circ)$, and $45$-in-$s$-out $I_p^{2\omega}(\phi=45^\circ)$ SHG signals for different angles of tilt $\theta$ about the axis $x$. The experimental data for $B$ and $C$ parameters (Fig. 3) is then fitted to Eq. (3) to extract the ratios $K_{15} = 0.20 \pm 0.01$, $K_{31} = 0.35 \pm 0.02$, and $K_{33} = -11.4 \pm 0.20$. By taking absorption into account, the estimated effective coefficients are

$$
|d_{22}| = 298.4 \pm 6.1 \text{ pm/V}, \quad |d_{31}| = 104.4 \pm 8.1 \text{ pm/V},
$$

$$
|d_{15}| = 59.7 \pm 4.2 \text{ pm/V}, \quad |d_{33}| = 3401 \pm 129 \text{ pm/V}.
$$

Note that only the signs of the ratios $K_{15}$, $K_{31}$, and $K_{33}$ were unambiguously determined. The absolute signs of the $d_{ij}$ coefficients were not determined, except to state that the $d_{33}$ coefficient has the opposite sign to the other coefficients. The large values of $d_{ij}$ coefficients most likely arise due to electronic resonances at the 400 nm SHG wavelength.

To conclude, we report the complex index of refraction versus wavelength and optical SHG coefficients in BiFeO$_3$ thin films. These studies will be important in performing further linear and nonlinear optical spectroscopies of the magnetism and ferroelectricity in this material.

We would like to acknowledge the support from NSF under Grant Nos. DMR-0507146, DMR-0512165, DMR-0602986, and DMR-0213623. At the University of Tennessee, the research was supported by the Materials Science Division, BES, U.S. DOE (DE-FG02-01ER45885).


